### Measurement of electronic structure and surface reconstruction in the superionic Cu<sub>2-x</sub>Te

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(Received 7 October 2020; revised 15 February 2021; accepted 5 March 2021; published 15 March 2021)

Recently, layered copper chalcogenides  $Cu_2X$  family (X=S, Se, Te) has attracted tremendous research interests due to their high thermoelectric performance, which is partly due to the superionic behavior of mobile Cu ions, making these compounds "phonon liquids." Here, we systematically investigate the electronic structure and its temperature evolution of the less studied single crystal  $Cu_{2-x}$ Te by the combination of angle resolved photoemission spectroscopy (ARPES) and scanning tunneling microscope/spectroscopy (STM/STS) experiments. While the band structure of the  $Cu_{2-x}$ Te shows agreement with the calculations, we clearly observe a 2 × 2 surface reconstruction from both our low temperature ARPES and STM/STS experiments which survives up to room temperature. Interestingly, our low temperature STM experiments further reveal multiple types of reconstruction patterns, which suggests the origin of the surface reconstruction being the distributed deficiency of liquidlike Cu ions. Our findings reveal the electronic structure and impurity level of  $Cu_2$ Te, which provides knowledge about its thermoelectric properties from the electronic degree of freedom.

DOI: 10.1103/PhysRevB.103.115127

#### I. INTRODUCTION

Thermoelectric (TE) materials play a vital role in the pursuit of green and renewable energy because it can realize direct conversion of waste heat to electric energy [1–3]. The TE performance of a material is evaluated by the dimensionless figure of merit (zT), defined as  $S^2\sigma T/\kappa$ , where S is the Seebeck coefficient,  $\sigma$  is electrical conductivity, T is the temperature, and  $\kappa$  is thermal conductivity coefficient. The search for TE materials with high zT value has become the central issue for the development of thermoelectric technology. The zT value can be enhanced by tuning the electron and phonon transports to achieve high electrical conductivity and low lattice thermal conductivity. Following such strategy, many types of TE materials have been synthesized and explored, greatly enhancing zT over the past decades [4–8].

Recently, copper chalcogenides compounds  $Cu_2X$  (X = S, Se, Te) have attracted lots of attention for their exceptionally low thermal conductivity and high TE performances [6,9–21]. The achieved zT is as high as 1.5 in  $Cu_{2-x}Se$ , 1.7 in  $Cu_{2-x}Se$ , and 1.1 in  $Cu_{2-x}Te$  at 1000 K, which are among

the top values in bulk TE materials. Comparing to  $\text{Cu}_2\text{S/Se}$ ,  $\text{Cu}_2\text{Te}$  is expected to have lower thermal conductivity due to heavier tellurium atoms and larger carrier mobility due to less electronegativity and less ionic bond strength, making  $\text{Cu}_2\text{Te}$  an important TE material candidate.

It is believed that the superionic diffusion of Cu ions, which suppresses the lattice thermal conductivity, plays an essential role in the high TE performance of Cu<sub>2</sub>X materials [6,11,19,21–27]. While the detailed structure and liquidlike behavior of Cu ions have been carefully studied in Cu<sub>2</sub>Se [6,10,26,28,29], the investigation on the electronic properties of Cu<sub>2</sub>Te is essentially lacking up to date, although the Cu ions are expected to be more mobile in Cu<sub>2</sub>Te due to the weaker ionic bonds. The previous studies on Cu<sub>2</sub>Te revealed a complicated phase diagram as a function of temperature with at least five different crystalline phases above room temperature (up to 900 K) [30,31]. Yet the low temperature phase of Cu<sub>2</sub>Te remains unexplored.

More importantly, the electronic degree of freedom also plays an important role in the TE performance of materials. For example, in our recent angle resolved photoemission spectroscopy (ARPES) study on  $\text{Cu}_2\text{Se}$ , we observed the band reconstruction across the  $\alpha$ - $\beta$  structural phase transition, leading to the enhancement of the Seebeck coefficient near 400 K [32]. However, the electronic structure of  $\text{Cu}_2\text{Te}$  and its temperature evolution remains nearly unexplored, despite several calculation results [33–38].

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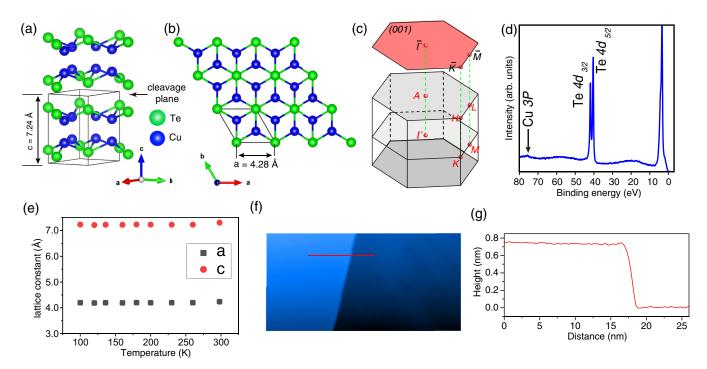


FIG. 1. Schematic drawing of the crystal structure of  $Cu_2Te$  (a) and top view of (001) plane (b). (c) Bulk and projected surface Brillouin zone (BZ) of (001) surface with high symmetry points indicated. (d) Photoemission core level spectrum of our  $Cu_{2-x}Te$  sample. (e) Extracted lattice constant from single crystal x-ray diffraction measurements at different temperatures. (f) Large scale STM topographic image on (001) plane with a sharp step,  $40 \text{ nm} \times 80 \text{ nm}$ ,  $U_s = 1 \text{ V}$ ,  $I_s = 250 \text{ pA}$ , 5.2 K. (g) Line profile along the red line in the (f) showing the step height.

These motivations inspire us to investigate the structural and electronic properties of Cu<sub>2</sub>Te at low temperature. X-ray diffraction (XRD) measurement confirms the lattice structure without structural transition from 100 K to room temperature. By performing ARPES measurement, we directly observe not only the complete band structure of Cu<sub>2</sub>Te which shows agreement with the calculation results, but also the folded band at the  $\bar{M}$  point up to room temperature, which strongly evidences the  $2 \times 2$  surface reconstruction. These findings are further confirmed by our scanning tunneling microscope (STM) surface topographic measurements. Moreover, our STM measurement reveals multiple surface reconstruction patterns in addition to the  $2 \times 2$  surface reconstruction. We speculate the large amount of Cu deficiencies that are uniformly distributed due to the liquidlike behavior of Cu ions leads to the ubiquitous surface reconstruction. Our result provides important information on the structural and electronic properties of Cu<sub>2-x</sub>Te, which provides knowledge about its TE properties from the electronic structure aspect.

#### II. METHODS

High-quality  $Cu_{2-x}$ Te single crystals were grown using the solid phase reaction. Cu (99.9%), Te (99.999%) powders in a molar ratio of 2 : 1 were mixed using a mortar for 30 min and placed into an alumina crucible. The crucible was sealed in a quartz ampoule under vacuum and subsequently heated to 850 °C in 10 h. After reaction at this temperature for 400 h, the ampoule was cooled to 300 °C in 100 h and cooled to room temperature in air.  $Cu_{2-x}$ Te single crystals with black shiny metallic luster were obtained.

Both ARPES and STM measurements were carried out in ultrahigh vacuum (UHV) environment. Fresh and clean surfaces of Cu<sub>2-x</sub>Te were obtained by in situ cleavage along (001) plane. ARPES experiments were performed at beamline 5-2 in Stanford Synchrotron Radiation Lightsource (SSRL), USA, beamline I05 in Diamond Light Source (DLS), UK, beamline APE in Elettra synchrotron, Italy and lab-based ARPES system in Tsinghua University, China. Experimental data were collected by Scienta R4000 analyzer at SSRL and DLS, DA30 analyzer at Elettra and Tsinghua University. The total convolved energy and angle resolution were better than 20 meV and 0.2°, respectively. In STM/STS experiments, cleaved samples were transferred to a cryogenic stage kept at 77 and 5.2 K for STM/STS experiments. PtIr tips were used for both imaging and tunneling spectroscopy measurements which were all calibrated on the surface of silver islands grown on p-type Si (111)  $7 \times 7$ . Lock-in technique was employed to obtain dI/dV curves with an extra 5 mV modulation at 997.233 Hz alongside the normal DC sample biases. In addition, the method of theoretical calculation is described in Appendix A.

### III. RESULTS AND DISCUSSION

 $\mathrm{Cu_2Te}$  has a hexagonal layeredlike crystal structure and its space group is  $P_{6/mmm}$  (no. 191). It is easily cleaved along the (001) plane to obtain a fully tellurium terminated surface, as shown in Figs. 1(a) and 1(b). The schematic of Brillouin zone (BZ) and its projection to (001) surface are shown in Fig. 1(c) with high symmetry points labeled. The photoemission core level spectrum of the cleaved sample is shown in Fig. 1(d). The characteristic peaks of  $\mathrm{Cu}\ 3p$  and  $\mathrm{Te}\ 3p$ 

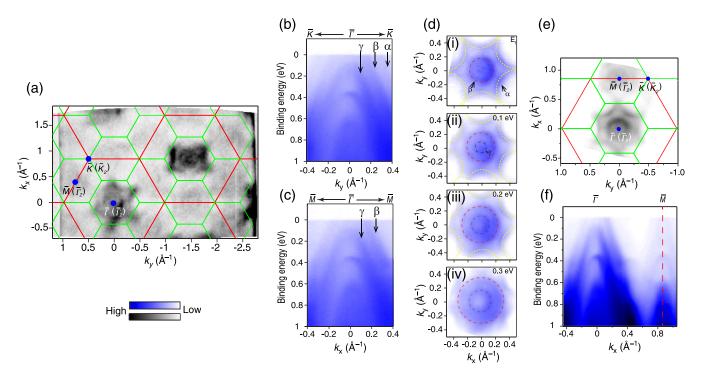


FIG. 2. (a) Broad Fermi surface (FS) map covering more than 1 BZ collected in 140-eV photons with linear horizontal polarization. (b) Band dispersions along  $\bar{K} - \bar{\Gamma} - \bar{K}$  from ARPES measurements. (c) Band dispersions along  $\bar{M} - \bar{\Gamma} - \bar{M}$  from ARPES measurements. (d) The constant energy contours around  $\bar{\Gamma}$  point at (i)  $E_F$ , (ii)  $E_b = 0.1 \, \text{eV}$ , (iii)  $E_b = 0.2 \, \text{eV}$ , (iv)  $E_b = 0.3 \, \text{eV}$ . FS map (e) and  $\bar{\Gamma} - \bar{M}$  dispersion (f) showing folded bands at  $\bar{M}$  point. Data in (b)–(f) were collected using 21-eV photons with circularly right polarization.

4d electrons are clearly observed in the photoemission core level spectrum. The crystal structure of  $Cu_{2-x}Te$  has been confirmed by the temperature dependent XRD measurements in Fig. 1(e). We do not observe any signature for structural transition from 100 K to room temperature. Large terraces with flat (001) surface and sharp step are obtained after cleavage, as shown in the large scale STM topographic image in Fig. 1(f). The measured step height is about 0.73 nm, which is consistent with the lattice constant c, given by the line profile in Fig. 1(g).

Electronic structures of Cu<sub>2-x</sub>Te are characterized by our high-resolution ARPES measurements in Fig. 2. The spectra are dominated by holelike bands located at the  $\bar{\Gamma}$  point of the primary BZ of Cu<sub>2</sub>Te as labeled by the red lines in Fig. 2(a). From the band dispersion along high-symmetry direction [Figs. 2(b) and 2(c)], three holelike bands can be clearly figured out near the Fermi energy  $(E_F)$  (labeled as  $\alpha$ ,  $\beta$ , and  $\gamma$ ). Among them, both the  $\alpha$  and  $\beta$  bands cross  $E_F$ , suggesting the crystals are heavily p doped. The band maximum of the shallow holelike  $\gamma$  band lies within 100 meV below  $E_F$ . The overall dispersion shows agreement with the theoretical calculations [20] (a detailed comparsion can be found in Appendix C). In order to show the symmetry and p-type nature of all the three hole bands, we plot several constant energy contours (CECs) around the  $\bar{\Gamma}$  point from  $E_F$ to binding energy  $E_b = 300 \,\mathrm{meV}$  with an energy interval of 100 meV in Fig. 2(d). From the Fermi surface (FS) [Fig. 2(d) (i)], only the  $\alpha$  and  $\beta$  bands can be observed. The outer  $\alpha$  band has a warping shaped band structure with sixfold symmetry. The inner  $\beta$  band is isotropic with the k vector equal to

about 0.15 Å<sup>-1</sup> at  $E_F$ . Below  $E_b = 100 \,\mathrm{meV}$ , all the three hole bands can be well resolved from the CECs [Fig. 2(d) (ii–iv)], where we can clearly see the  $\gamma$  band is also isotropic. All these three pockets expand with increasing  $E_b$ , consistent with their holelike nature. A simple electron counting on the holelike pockets on  $E_F$  suggests a three dimensional carrier concentration of  $(2.4 \pm 0.8) \times 10^{21} \, \mathrm{cm}^{-3}$  (a detailed analysis can be found in Appendix B), and the calculated carrier concentration is  $4 \times 10^{21} \,\mathrm{cm}^{-3}$  ( $E_b = 640 \,\mathrm{meV}$ , T =14 K). The carrier concentration obtained from the experiment shows agreement with the calculated results and other recent transport measurement of the as-grown  $Cu_{2-x}$ Te sample [16]. We note that the abundant copper vacancies as hole donors in  $Cu_{2-x}$ Te bulk materials mainly contribute to the heavy p-doped nature of its electronic structure (see discussions below).

In addition to the main band feature, from Fig. 2(a) we could observe clear folded bands at the  $\bar{M}$  point (although with weak intensity) of the primary BZ of Cu<sub>2</sub>Te which is a strong evidence of the existence of  $2 \times 2$  surface reconstruction. In order to better illustrate the surface reconstruction, we plot the  $2 \times 2$  BZ (green) with reference to the  $1 \times 1$  primitive BZ (red) in Fig. 2(a), where  $\bar{\Gamma}$ ,  $\bar{M}$ , and  $\bar{K}$  represent the high symmetric points in the  $1 \times 1$  BZ and  $\bar{\Gamma}_2$ ,  $\bar{M}_2$ , and  $\bar{K}_2$  represent the high symmetric points in the  $2 \times 2$  BZ. We plot the detailed CECs at  $E_F$  as well as the dispersion along the high symmetry direction in Figs. 2(e) and 2(f), which clearly illustrates the folded bands showing great resemblance to the main bands in terms of the shape and size (a detailed analysis can be found in Appendix D).

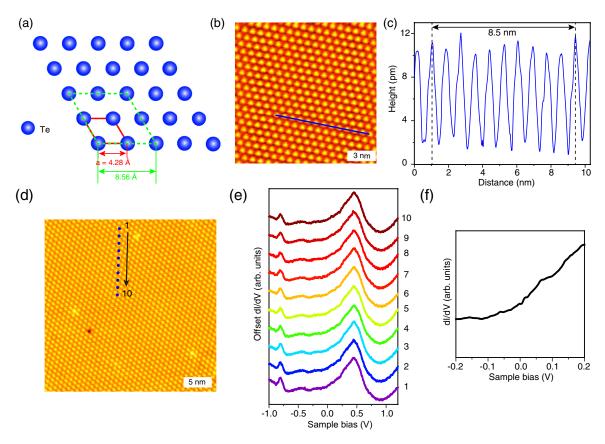


FIG. 3. (a) Schematic drawing of the crystal structure of  $Cu_2Te$  (001) plane, with  $1 \times 1$  primitive cell and  $2 \times 2$  supercell indicated by red and green parallelogram, respectively. (b) STM image showing clear  $2 \times 2$  reconstruction on  $Cu_{2-x}Te$  (001) surface,  $15 \text{ nm} \times 15 \text{ nm}$ ,  $U_s = -1 \text{ V}$ ,  $I_s = 250 \text{ pA}$ . (c) Line profile along the blue line in (b). (d) STM topographic image on  $Cu_{2-x}Te$ ,  $30 \text{ nm} \times 30 \text{ nm}$ ,  $U_s = -1 \text{ V}$ ,  $I_s = 250 \text{ pA}$ . (e) A series of dI/dV spectra along the defined blue dots in (d) with sample bias from -1 to +1.2 V. (f) dI/dV spectrum with high energy resolution with sample bias from -200 to +200 mV showing detailed density of states near  $E_F$ . All data were collected at 5.2 K.

The existence of the  $2 \times 2$  surface reconstruction of the  $Cu_{2-x}Te$  samples is further confirmed by our STM measurement. The schematic drawing of the topmost atoms of the (001) plane (natural cleavage plane) of  $Cu_2Te$  is shown in Fig. 3(a). The most adjacent tellurium atoms (blue) in a hexagonal lattice give rise to the  $1 \times 1$  lattice structure of  $Cu_2Te$  with lattice constant a = b = 4.28 Å. The reconstructed  $2 \times 2$  supercell is marked with a green dotted line with lattice constant 2a = 8.56 Å. Figure 3(b) shows an STM atomic resolution image of the  $Cu_{2-x}Te$  surface, from which the hexagonal arrangement periods of the  $2 \times 2$  surface reconstruction are directly observed. The distance between two bright dots is 0.85 nm, identical to twice the in-plane lattice constant of  $Cu_2Te$ , analyzed from the line profile [Fig. 3(c)] across at least ten bright dots along the blue line in Fig. 3(b).

In order to better reveal the electronic structure of the  $Cu_{2-x}Te$  samples with STM, we measure a series of dI/dV spectra on a large  $2 \times 2$  area along a defined line (including ten points with equal spacing of  $\sim 11.5$  nm) superimposed on the clear STM topographic image in Fig. 3(d). All the dI/dV curves are collected sequentially in Fig. 3(e). We find the density of states (DOS) is rather uniform and independent with locations within a large scale of sample bias (-1.0 to)

+1.2 V). Importantly, the dI/dV curves again reveal that the Cu<sub>2-x</sub>Te sample in our measurement is heavily p doped because the minimum value of DOS is located at about +0.9 eV, which is consistent with our ARPES results. From our STS results as well as the higher energy resolution spectra within a much smaller bias range near  $E_F$  (-0.2 to +0.2 V), we could find that the DOS around the  $E_F$  is gapless in Fig. 3(f). The absence of the gaplike feature suggests that charge density wave is unlikely the origin of the observed  $2 \times 2$  surface reconstruction.

The detailed ARPES temperature dependence measurements provide further comprehension of the  $2 \times 2$  reconstruction. Figure 4(a) illustrates the dispersion along the high symmetry  $\bar{M}$ - $\bar{\Gamma}$ - $\bar{M}$  direction at various temperatures and Fig. 4(b) shows the comparison of the CECs at FS at different temperatures. We find that the reconstructed hole pockets at  $\bar{M}$  in the  $1 \times 1$  BZ (or  $\bar{\Gamma}_2$  in the  $2 \times 2$  BZ) could be observed at all temperatures from 5.2 to 280 K. We analyze the temperature evolution of integrated photoemission intensity of the main bands near  $\bar{\Gamma}$  (integrated over the green dashed rectangle area) and the reconstructed bands near  $\bar{M}$  (integrated over the red dashed rectangle area) [Fig. 4(c)] and find that their intensity both gradually decrease as the temperature rises due

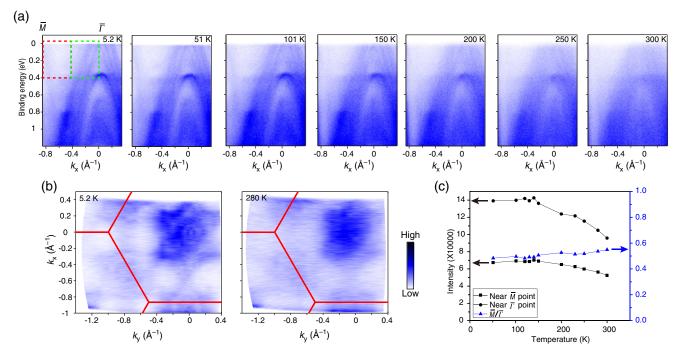


FIG. 4. (a) Band structures of  $Cu_{2-x}$ Te measured along  $\bar{M} - \bar{\Gamma} - \bar{M}$  at different temperatures. (b) Fermi surface of  $Cu_{2-x}$ Te measured at 5.2 and 280 K, respectively. All data were collected using 21.2-eV photons. (c) Temperature evolution of integrated photoemission intensity of main bands [integrated over the green dashed rectangle area in (a)], reconstructed bands [integrated over the red dashed rectangle area in (a)], and their ratio.

to the increased scattering and suppression of the quasiparticle peak; meanwhile the ratio of the integrated intensity near the  $\bar{M}$  point to the  $\bar{\Gamma}$  point [blue line in Fig. 4(c)] increases slightly as the temperature rises, suggesting that the 2 × 2 reconstruction persists up to room temperature.

Finally, we observe other types of surface reconstruction using STM at different surface regimes. Figures 5(a)-5(d) demonstrate several reconstructed patterns, including the  $2 \times 2$ ,  $\sqrt{3} \times \sqrt{3}$ ,  $2\sqrt{3} \times 2\sqrt{3}$  and their combinations. These extra surface reconstruction was not captured by our ARPES measurements, possibly because the  $2 \times 2$  reconstruction dominates the sample surface.

As stated in the previous experimental reports of  $Cu_{2-x}Te$ , a large amount of Cu deficiencies were inevitable in Cu<sub>2-x</sub>Te [12,15,16,18]. The liquidlike Cu ions [6,8] could further lead to the even distribution of the deficiencies and the formation of the ordered surface reconstruction. Although we have not directly observed the distribution of the copper ions inside the material from our surface-sensitive ARPES and STM measurements, our observation provides an important clue on the Cu deficiency level as well as the abundant local defects (which exists at the boundary of different reconstructed areas), which would contribute greatly to the electrical and thermal conductivity in  $Cu_{2-x}$ Te. All these parameters are critical for the thermoelectric performance of  $Cu_{2-x}Te$  ( $zT = S^2 \sigma \kappa^{-1}T$ , where S is the Seebeck coefficient,  $\sigma$  is the electrical conductivity, and  $\kappa$  is the thermal conductivity), therefore, we believe our results would provide valuable information for the investigation and optimization of the thermoelectric performance in Cu<sub>2-x</sub>Te. In comparison, in the other copper chalcogenide Cu<sub>2</sub>Se, we discovered a  $\sqrt{3} \times \sqrt{3}$  reconstruction due to the Cu ion deficiency order in its low temperature  $\alpha$  phase [32] which goes away across the  $\alpha$ - $\beta$  phase transition together with melting the Cu ion deficiency order and a peak in the Seebeck coefficient  $\sim$ 400 K. It is possible that the observed

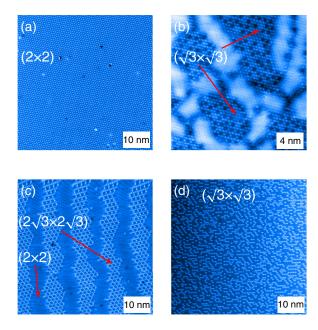


FIG. 5. (a)–(d) STM topographic images showing several reconstruction phases found in our Cu<sub>2-x</sub>Te samples: (a)  $2 \times 2$  phase. (b) Type  $A \sqrt{3} \times \sqrt{3}$  phase. (c)  $2 \times 2$  and  $2\sqrt{3} \times 2\sqrt{3}$  mixed phase. (d) Type  $B \sqrt{3} \times \sqrt{3}$  phase. The measurement settings are (a)  $50 \text{ nm} \times 50 \text{ nm}$ ,  $U_s = -1 \text{ V}$ ,  $I_s = 250 \text{ pA}$ , 5.2 K; (b)  $30 \text{ nm} \times 30 \text{ nm}$ ,  $U_s = 1 \text{ V}$ ,  $I_s = 350 \text{ pA}$ , 5.2 K; (c)  $50 \text{ nm} \times 50 \text{ nm}$ ,  $U_s = 1 \text{ V}$ ,  $I_s = 250 \text{ pA}$ , 77 K; (d)  $50 \text{ nm} \times 50 \text{ nm}$ ,  $U_s = 1 \text{ V}$ ,  $I_s = 250 \text{ pA}$ , 77 K.

Cu ion deficiency order in  $Cu_{2-x}$ Te would also melt at elevated temperatures and greatly improve the TE performance of  $Cu_2$ Te [12]. We also note that annealing the sample could increase the thermopower and decrease the thermal conductivity, therefore boost the zT value by controlling Cu deficiency level [12], suggesting the key role Cu deficiency plays in determination of the TE performance of  $Cu_2$ Te.

#### IV. SUMMARY

In summary, we have investigated the electronic structure and surface topography of the cleaved  $Cu_{2-x}Te$  single crystals through ARPES and STM measurements. Both our ARPES experiments (showing a multiple hole-bands feature near  $E_F$ ) and STS dI/dV results reveal a heavily p-doped electronic band structure in  $Cu_{2-x}Te$  samples, which is most likely induced by the large amount of copper vacancies in this material. Moreover, our ARPES and STM/STS studies reveal a  $2 \times 2$  surface reconstruction, which survives up to room temperature. The origin of the surface reconstruction seems to be the distributed Cu deficiencies due to the "liquidlike" Cu ions. Our experimental research provides critical information of the electronic structures of  $Cu_{2-x}Te$  at low temperature and suggests the control of the Cu deficiency may enhance the TE performance in  $Cu_2Te$ .

#### ACKNOWLEDGMENTS

The work was supported by the National Key R&D program of China (Grants No. 2017YFA0305400 and No. 2018YFA0307000) and the National Natural Science Foundation of China (Grants No. 11774190 and No. 11874022). M.X.W. acknowledges the support from the National Natural Science Foundation of China (Grant No. 11604207). Use of the Stanford Synchrotron Radiation Light Source, SLAC National Accelerator Laboratory, was supported by the U.S. Department of Energy, Office of Science, Office of Basic Energy Sciences under Contract No. DE-AC02-76SF00515. This research used resources of the Advanced Light Source, a U.S. DOE Office of Science User Facility under Contract No. DE-AC02-05CH11231 and Diamond Light Source (Proposal No. SI25135-1).

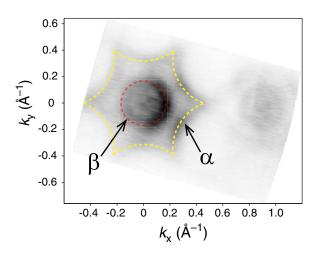


FIG. 6. Fermi surface of  $Cu_{2-x}$ Te.

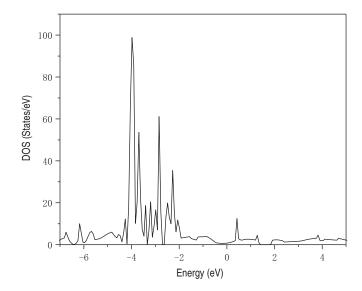


FIG. 7. Calculated total density of states (DOS) of Cu<sub>2</sub>Te.

All authors contributed to the scientific planning and discussions.

# APPENDIX A: METHODS ABOUT THE THEORETICAL CALCULATION

The present calculations have been performed using the DFT code VASP [39–41], which is an implementation of the projector augmented wave (PAW) method. We chose the general gradient approximation (GGA) in Perdew-Burke-Ernzerhof (PBE) implementation [42] to be the exchange correlation functional. The cutoff energy of the plane-wave basis was set as 600 eV, and the Brillouin zone (BZ) was sampled by the  $5 \times 5 \times 5$  meshes in the self-consistent calculations. The energy and force difference criterion were defined as  $10^{-6}$  eV and 0.01 eV/Å for self- consistent convergence and structural relaxation, respectively.

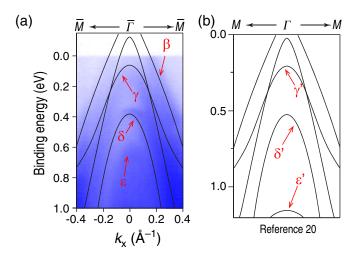


FIG. 8. (a) Band dispersions along  $\bar{M} - \bar{\Gamma} - \bar{M}$  directions obtained by our ARPES experiments data overlapped with calculation results from Ref. [20] (black curves). (b) The calculated band structure along  $\bar{M} - \bar{\Gamma} - \bar{M}$  directions extracted from Ref. [20].

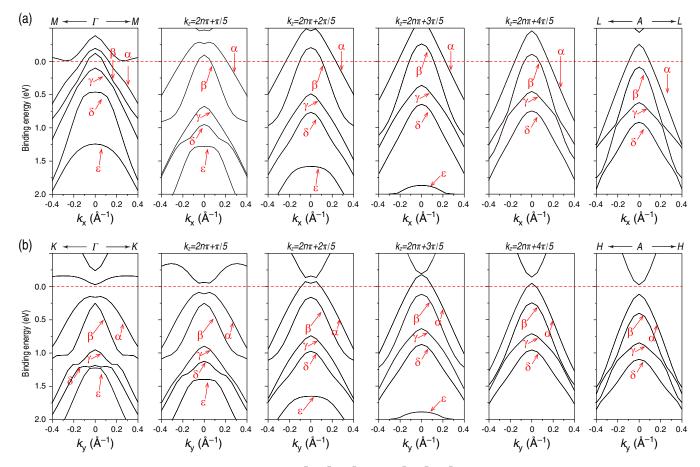


FIG. 9. Calculated dispersions along (a)  $\bar{M} - \bar{\Gamma} - \bar{M}$  and (b)  $\bar{K} - \bar{\Gamma} - \bar{K}$  direction at different  $k_z$  values.

# APPENDIX B: ESTIMATE OF THE CARRIER CONCENTRATION IN $Cu_{2-x}$ Te

The Luttinger theorem states that the volume enclosed by a material's Fermi surface is directly proportional to the particle density,

$$n = 2 \int_{G(\omega=0,p)>0} \frac{d^D k}{(2\pi)^D},$$
 (B1)

where G is the single-particle Green function in terms of frequency and momentum and  $d^D k$  is the differential volume of k space in D dimensions [43,44].

In our paper, we estimate the carrier concentration by calculating the area of the hole pockets ( $\alpha$  and  $\beta$ ) of the Fermi

Pocket size in segment X = experimental value obtained  $\times$ 

Finally, by summing them up to obtain the 3D carrier concentration  $(2.4 \times 10^{21} \, \text{cm}^{-3})$  we could include the effect of the  $k_z$  dispersion and provide a better estimate of the 3D carrier concentration. The uncertainty of such estimate

surface (Fig. 6). Equation (B1) can be written as follows:

$$n = 2 \times \frac{\mathbf{S}}{(2\pi)^2}.$$
(B2)

By calculating their individual area (the estimated shape of the  $\alpha/\beta$  pocket is marked in Fig. 6 by the yellow/red dashed lines, respectively), we evaluate the two-dimensional carrier concentration of the  $\alpha/\beta$  pocket to be

$$n_{2D} = 2 \times \frac{S_{\alpha} + S_{\beta}}{\left(2\pi\right)^2}.$$
 (B3)

Then, by comparing with the  $k_z$  dependent calculations, we estimate the rough  $k_z$  value of our measurement between  $\pi/5$  and  $2\pi/5$  (Fig. 10). We divide the full  $k_z$  range into five segments, each of which has a span of  $\pi/5$ . Within each segment, the  $k_z$  dispersion of the pocket is ignored. The pocket size in segment X is estimated as

calculation result of the pocket size in segment *X* calculation result of the pocket size in segment  $\pi/5 \rightarrow 2\pi/5$ 

mainly comes from the accuracy of the  $k_z$  dispersion and is evaluated as the difference between the largest and smallest pocket size (and converted to the 3D concentration) which are  $1.64 \times 10^{21} \, \mathrm{cm}^{-3}$  and  $3.24 \times 10^{21} \, \mathrm{cm}^{-3}$ , respectively.

Therefore, we estimate the 3D carrier concentration to be  $(2.4 \pm 0.8) \times 10^{21} \,\mathrm{cm}^{-3}$ .

In addition, we used first-principles calculations to calculate the carrier concentration. The *n-type* and *p*-type carrier concentration could be derived from the density of states (DOS) and the Fermi-Dirac distribution function  $f(\varepsilon)$  as

$$n = \int_{F_{max}}^{\infty} D_C(\varepsilon) f(\varepsilon) d\varepsilon, \tag{B4}$$

$$n = \int_{E_{\text{CBM}}}^{\infty} D_C(\varepsilon) f(\varepsilon) d\varepsilon, \tag{B4}$$

$$p = \int_{-\infty}^{E_{\text{VBM}}} D_V(\varepsilon) [1 - f(\varepsilon)] d\varepsilon, \tag{B5}$$

where  $D_C(\varepsilon)$  and  $D_V(\varepsilon)$  are the DOS of the conduction band and valence band, respectively. We calculated the DOS by first principle calculations, and the results are shown in Fig. 7. The calculated DOS together with the position of Fermi level determined by ARPES measurement would allow us to obtain the p-type carrier concentration which equals  $4.00 \times 10^{21} \,\mathrm{cm}^{-3} \,(T = 14 \,\mathrm{K}).$ 

### APPENDIX C: DETAILED $k_z$ CALCULATION RESULTS ARE COMPARED WITH THE EXPERIMENTAL DATA

Figures 8(a) and 8(b) show the comparison of the calculated band structure and our experimental results. The high binding energy  $(E_B)$  hole band (labeled as  $\varepsilon$ ) with its band maximum at  $\sim 0.6$  eV in our experiment is inconsistent with the calculation results in Ref. [20] which gives the position  $\sim$ 1.15 eV.

We think the inconsistency is mainly due to the different  $k_{\tau}$ value between our ARPES results taken with 21.2 eV photon energy and the first-principles calculation  $(k_z = 0)$  from the literature. To address this point, we perform first-principles calculation of Cu<sub>2</sub>Te on our own, and the results are shown in Fig. 9.

With the  $k_z$  values varying from  $k_z = 0$  to  $k_z = \pi$ , the energy positions of the five hole bands evolve with different  $k_z$ . As shown in Fig. 9, the  $\varepsilon$  band, for example, has a great change in the energy position with different  $k_z$ . Therefore it would be inaccurate to directly compare our ARPES data with the calculation results without any consideration of the  $k_z$  effect.

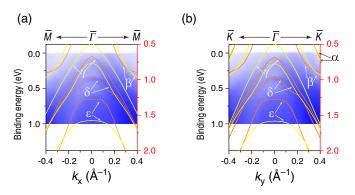


FIG. 10. Calculated dispersions at different  $k_z$  values (orange:  $k_z = \pi/5$ ; yellow:  $k_z = 2\pi/5$ ) were appended to experimental data along (a)  $\bar{M} - \bar{\Gamma} - \bar{M}$  and (b)  $\bar{K} - \bar{\Gamma} - \bar{K}$  direction. The coordinate axis on the left and right are the binding energy of the experiment results and calculation results, respectively.

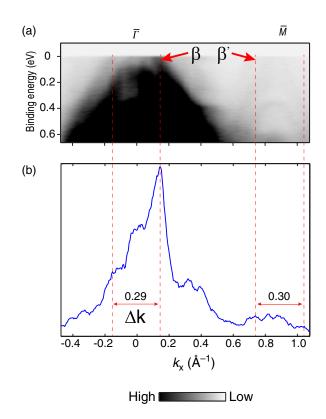


FIG. 11. (a) Photoemission intensity of the band dispersion along  $\bar{M}$ - $\bar{\Gamma}$ - $\bar{M}$ . (b) Momentum distribution curve at  $E_F$ . Data were collected using 21-eV photons with circularly right polarization.

We estimate the  $k_z$  position by stacking the calculated band structure  $(\gamma, \delta, \varepsilon)$  with two different  $k_z$  values  $(k_z = \pi/5, \varepsilon)$  $2\pi/5$ ) since the  $k_7$  broadening effect should be included into consideration at lower photon energies, and compare them with our own experimental data, as shown in Fig. 10. We found that the calculation results between  $k_z = \pi/5$  and  $2\pi/5$ shows better agreement with our experimental data (but not perfectly). Especially, the broad continuum sitting between  $E_B \sim 0.75$  and 1 eV could be explained by rapid  $k_z$  evolution of the  $\varepsilon$  band from  $k_z = \pi/5$  to  $2\pi/5$ .

For the best match between the calculated band structure and measured spectrum we have to shift the  $E_F$  in the calculation by about 0.6 eV, as shown in Fig. 10. The rigid shift

TABLE I. EDS composition of our samples.

Number of region	Atomic conc. of Cu (%)	Atomic conc. of Te (%)	Ratio Cu/Te
1	65.66	34.34	1.912
2	61.72	38.28	1.612
3	62.97	37.03	1.701
4	65.06	34.94	1.862
5	64.78	35.22	1.839
6	66.02	33.98	1.943
7	63.95	36.05	1.774
8	66.59	33.41	1.993
9	65.22	34.78	1.875
Average			1.823

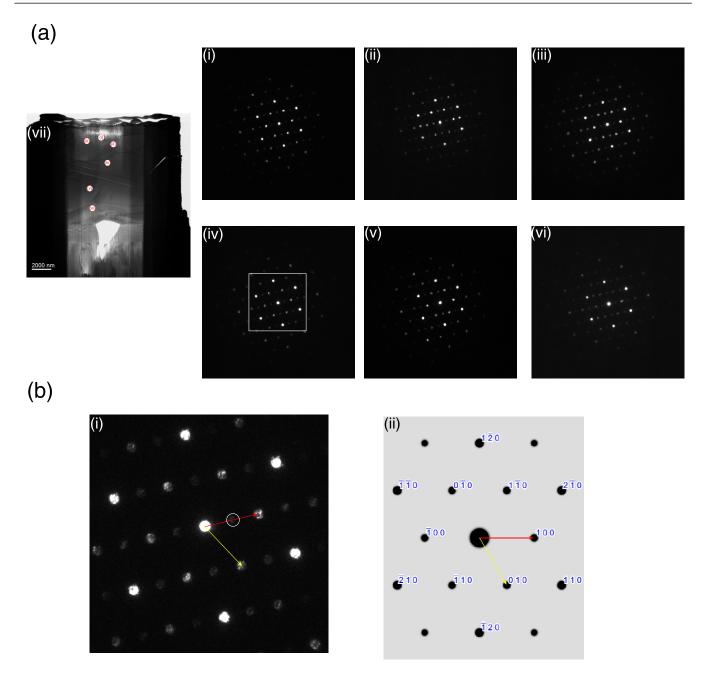


FIG. 12. (a) Electron diffraction pattern obtained by TEM measurement. (i)—(vi) show diffraction results obtained at six different locations. (b) (i) Zoomed-in image in the white square given in (a) (iv) showing clearer diffraction pattern. (ii)  $Cu_2Te$  (001) plane diffraction pattern simulated by CRYSTALMAKER software.

required is due to the charge doping effect caused by the large amount of copper vacancies in this material.

# APPENDIX D: DETAILED ANALYSIS OF THE SIZE OF THE FOLDED BANDS AND MAIN BANDS

In order to better compare the size of the folded bands with main bands, we analyze the momentum distribution curve (MDC) at  $E_F$  along the  $\bar{\Gamma}$ - $\bar{M}$  directions, and determine the size  $\Delta k$  of the  $\beta$  pocket (main band) and the  $\beta'$  pocket (folded band) by the positions of the peaks in the MDC (Fig. 11). We find that the  $\Delta k$  of the  $\beta$  pocket and  $\beta'$  pocket are  $\sim 0.29 \,\text{Å}^{-1}$ 

and  $\sim 0.30 \, \text{Å}^{-1}$ , respectively. Given the much weaker intensity of the  $\beta'$  pocket, we conclude that  $\beta'$  is the folded band of the primary  $\beta$  band.

# APPENDIX E: DETAILED ANALYSIS OF Cu VACANCIES LEVEL BY ENERGY DISPERSIVE X-RAY SPECTROSCOPY

The Cu vacancies level could be quantitatively measured from the energy dispersive x-ray spectroscopy (EDS) measurement. From nine spots on the samples, EDS suggests our  $\text{Cu}_{2-x}\text{Te}$  samples have (2-x) from 1.612 to 1.993 (the results are listed in Table I) with the average value  $\sim 1.823 \pm 0.114$ .

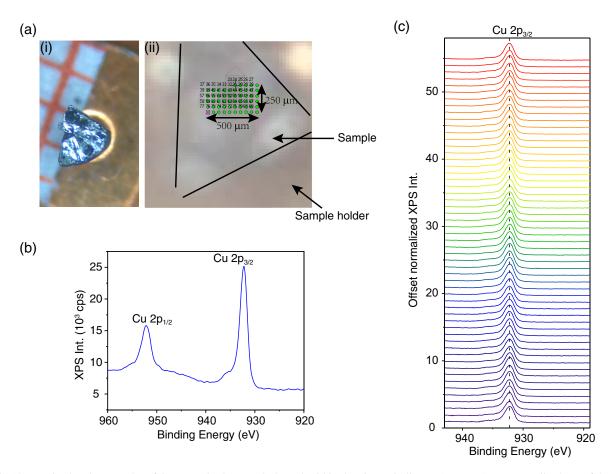


FIG. 13. (a) (i) The photography of  $Cu_{2-x}$ Te single crystal; the red grid in the picture indicates 1 mm  $\times$  1 mm area; (ii) photo of the sample at the XPS test position; clearly seen is the sample profile surrounded by three black lines as shown in (i). (b) The XPS spectrum of Cu 2p. The binding energy position of the peaks are 932.2 eV (Cu  $2p_{3/2}$ ) and 952.0 eV (Cu  $2p_{1/2}$ ). (c) Stack of the 55 XPS spectra for the Cu  $2p_{1/2}$  peak in different positions with the 55 positions shown in the green dots of (a) (ii). The background of these spectra have been normalized.

### APPENDIX F: SELECTED AREA ELECTRON DIFFRACTION AND X-RAY PHOTOELECTRON SPECTROSCOPY CHARACTERIZATION OF OUR SAMPLES

In addition, we have tried to investigate the fraction of different reconstruction patterns. We carried out transmission electron microscope (TEM) measurements on thin samples prepared by focused ion beam technique. On a sample area  $7.5 \times 15 \mu m$ , we randomly selected six locations [shown in Fig. 12(a) (vii)] to measure the diffraction pattern, as shown in Fig. 12(a) (i)–(vi). We find that the diffraction pattern at different positions are almost the same, except for the difference in intensity. By zooming in the area indicated by white square in Fig. 12(a) (iv) and comparing with the simulated diffraction pattern from the Cu<sub>2</sub>Te lattice [Fig. 12(b)], we found an extra set of diffraction spots in addition to the lattice

diffraction points [marked with white circles in Fig. 12(b) (i)] which suggests that a  $2 \times 1$  reconstruction is observed in thin films of Cu<sub>2</sub>Te.

In order to characterize the distribution of defects, we also carried out scanning x-ray photoelectron spectroscopy (XPS), as shown in Fig. 13. First, we collected a typical XPS spectrum of  $\text{Cu}_{2-x}\text{Te}$ , as shown in Fig. 13(b). The binding energy positions of  $\text{Cu}\ 2p_{3/2}$  and  $\text{Cu}\ 2p_{1/2}$  are at 932.2 and 952.0 eV, respectively, in good agreement with Cu (I) chalcogenides, as previously reported for  $\text{Cu}_2\text{Te}\ [45]$ . Then, we focus on the peak of  $\text{Cu}\ 2p_{3/2}$ , and follow the grid  $(500 \times 250\ \mu\text{m};$  the distance between each point is 50  $\mu\text{m}$  and the typical beam spot size is  $\sim 10\ \mu\text{m}$ ) in Fig. 13(a) (ii) to collect spectra point by point. The results are shown in Fig. 13(c), obviously, there is no shift in the peak position, indicating that the valence of Cu ions in our sample has no observable change.

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